

Search Notes

Application/Control No.

10/533,893

Examiner

Evan Dzierzynski

Applicant(s)/Patent under
Reexamination

MASUDA, TAKESHI

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	617	7/20/2006	ED
	19	7/20/2006	ED
	615	7/20/2006	ED
	616	7/20/2006	ED
	600	7/20/2006	ED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search advice from Ali Alavi	7/20/2006	ED
EAST word search, attached	7/20/2006	ED